# **BUK7C10-75AITE**

# N-channel TrenchPLUS standard level FET

Rev. 03 — 17 February 2009

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Product data sheet

### 1. Product profile

#### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS current sensing and diodes for ElectroStatic Discharge (ESD) protection and temperature sensing. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

#### 1.2 Features and benefits

- Allows responsive temperature monitoring due to integrated temperature sensor
- Electrostatically robust due to integrated protection diodes
- Low conduction losses due to low on-state resistance
- Q101 compliant
- Reduced component count due to integrated current sensor

#### 1.3 Applications

- Automotive and general purpose power switching
- Fan control

- Electrical Power Assisted Steering (EPAS)
- Variable Valve Timing for engines

#### 1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	-	75	V
I <sub>D</sub>	drain current	$V_{GS} = 10 \text{ V}$ ; $T_{mb} = 25 \text{ °C}$ ; see <u>Figure 2</u> ; [1] see <u>Figure 3</u>	-	-	114	Α
Static cha	racteristics					
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS}$ = 10 V; $I_D$ = 50 A; $T_j$ = 25 °C; see Figure 7; see Figure 8	-	8.8	10	mΩ
I <sub>D</sub> /I <sub>sense</sub>	ratio of drain current to sense current	$T_j > -55 \text{ °C}; T_j < 175 \text{ °C}; V_{GS} > 10 \text{ V}$	450	500	550	
S <sub>F(TSD)</sub>	temperature sense diode temperature coefficient	$I_F = 250 \mu A; T_j > -55 °C; T_j < 175 °C$	-1.4	-1.54	-1.68	mV/K
V <sub>F(TSD)</sub>	temperature sense diode forward voltage	$I_F = 250 \mu A; T_j = 25 °C$	648	658	668	mV

[1] Current is limited by power dissipation chip rating.



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# 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		d a
2	ISENSE	sense current	mb	, u
3	А	anode		
4	D	drain	ii	. (
5	K	cathode		
6	KS	Kelvin source		<b>▼</b> ••••••••••••••••••••••••••••••••••••
7	S	source	SOT427	MBL362 sense Kelvin source
mb	D	mounting base; connected to drain	(D2PAK)	MD2002 SGISE REWITSOUTCE

# 3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
BUK7C10-75AITE	D2PAK	plastic single-ended surface-mounted package (D2PAK); 7 leads (one lead cropped)	SOT427		

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## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	75	V
$V_{DGS}$	drain-gate voltage			-	75	V
$V_{GS}$	gate-source voltage			-20	20	V
I <sub>D</sub>	drain current	$T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 2</u> ;	[1]	-	114	Α
		see Figure 3	[2]	-	75	Α
		T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; see <u>Figure 2</u>	[2]	-	75	Α
I <sub>DM</sub>	peak drain current	$T_{mb}$ = 25 °C; $t_p \le 10 \mu s$ ; pulsed; see Figure 3		-	456	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 1</u>		-	272	W
I <sub>GS(CL)</sub>	gate-source clamping	continuous		-	10	mA
	current	pulsed; $t_p = 5$ ms; $\delta = 0.01$		-	50	mA
V <sub>isol(FET-TSD)</sub>	FET to temperature sense diode isolation voltage			-100	100	V
T <sub>stg</sub>	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
Source-drai	n diode					
Is	source current	T <sub>mb</sub> = 25 °C	[1]	-	114	Α
			[2]	-	75	Α
I <sub>SM</sub>	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	456	Α
Avalanche r	uggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 75 A; $V_{sup}$ ≤ 75 V; $R_{GS}$ = 50 $\Omega$ ; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; unclamped		-	739	mJ
Electrostation	c discharge					
V <sub>esd</sub>	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 kΩ		-	6	kV

<sup>[1]</sup> Current is limited by power dissipation chip rating.

<sup>[2]</sup> Continuous current is limited by package.

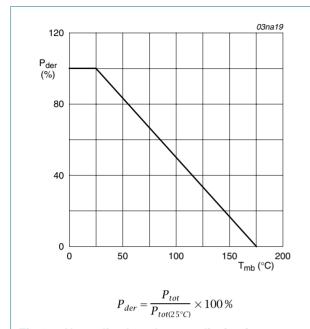


Fig 1. Normalized total power dissipation as a function of mounting base temperature

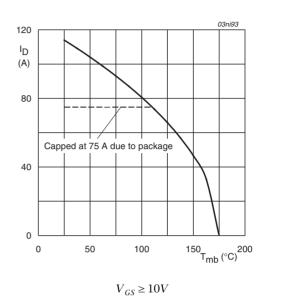
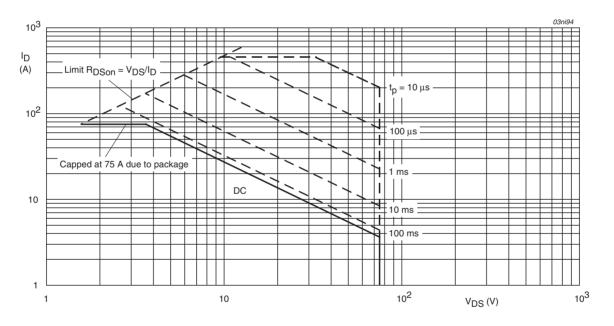


Fig 2. Normalized continuous drain current as a function of mounting base temperature



 $T_{mb} = 25$ °C;  $I_{DM}$  is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

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### 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	mounted on printed-circuit board; minimum footprint	-	-	50	K/W
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	0.55	K/W

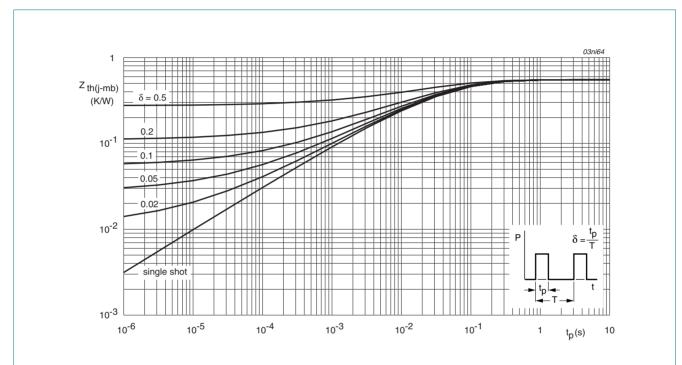


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

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## 6. Characteristics

Table 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V <sub>(BR)DSS</sub>	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	75	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	70	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see Figure 9	2	3	4	V
		$I_D = 1 \text{ mA}$ ; $V_{DS} = V_{GS}$ ; $T_j = 175 \text{ °C}$ ; see Figure 9	1	-	-	V
		$I_D = 1 \text{ mA}$ ; $V_{DS} = V_{GS}$ ; $T_j = -55 \text{ °C}$ ; see Figure 9	-	-	4.4	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 75 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.1	10	μΑ
		$V_{DS} = 75 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	250	μΑ
$V_{(BR)GSS}$	gate-source breakdown voltage	$I_G = 1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C};$ $T_j < 175 \text{ °C}$	20	22	-	V
		$I_G = -1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C};$ $T_j < 175 \text{ °C}$	20	22	-	V
I <sub>GSS</sub>	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}$	-	22	1000	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 25 \text{ °C}$	-	22	1000	nA
		V <sub>DS</sub> = 0 V; V <sub>GS</sub> = 10 V; T <sub>j</sub> = 175 °C	-	-	10	μΑ
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 175 \text{ °C}$	-	-	10	μA
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 7</u> ; see <u>Figure 8</u>	-	8.8	10	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see <u>Figure 7</u> ; see <u>Figure 8</u>	-	-	21	mΩ
$V_{F(TSD)}$	temperature sense diode forward voltage	$I_F = 250 \mu A; T_j = 25 \text{ °C}$	648	658	668	mV
S <sub>F(TSD)</sub>	temperature sense diode temperature coefficient	$I_F = 250 \mu A; T_j > -55 \text{ °C}; T_j < 175 \text{ °C}$	-1.4	-1.54	-1.68	mV/K
V <sub>F(TSD)hys</sub>	temperature sense diode forward voltage hysteresis	$I_F > 125 \mu A; I_F < 250 \mu A; T_j = 25 °C$	25	32	50	mV
I <sub>D</sub> /I <sub>sense</sub>	ratio of drain current to sense current	$V_{GS} > 10 \text{ V; } T_j > -55 \text{ °C; } T_j < 175 \text{ °C}$	450	500	550	
Dynamic o	characteristics					
$Q_{G(tot)}$	total gate charge	$I_D = 25 \text{ A}$ ; $V_{DS} = 60 \text{ V}$ ; $V_{GS} = 10 \text{ V}$ ;	-	121	-	nC
$Q_{GS}$	gate-source charge	T <sub>j</sub> = 25 °C; see <u>Figure 14</u>	-	20	-	nC
$Q_{GD}$	gate-drain charge		-	44	-	nC
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	4700	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 12</u>	-	800	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	455	-	pF

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Table 6. Characteristics ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 30 V; $R_L$ = 1.2 $\Omega$ ; $V_{GS}$ = 10 V;	-	35	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 10 \Omega$ ; $T_j = 25 °C$	-	108	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	185	-	ns
t <sub>f</sub>	fall time		-	100	-	ns
L <sub>D</sub>	internal drain inductance	from upper edge of drain mounting base to center of die; $T_j = 25$ °C	-	2.5	-	nΗ
L <sub>S</sub>	internal source inductance	from source lead to source bond pad; $T_j = 25 ^{\circ}\text{C}$	-	7.5	-	nΗ
Source-dr	rain diode					
$V_{SD}$	source-drain voltage	$I_S = 25 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see Figure 18	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 20 \text{ A}$ ; $dI_S/dt = -100 \text{ A/}\mu\text{s}$ ; $V_{GS} = -10 \text{ V}$ ;	-	75	-	ns
Q <sub>r</sub>	recovered charge	$V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$	-	270	-	nC

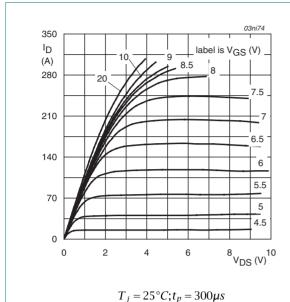
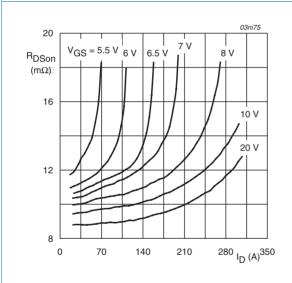
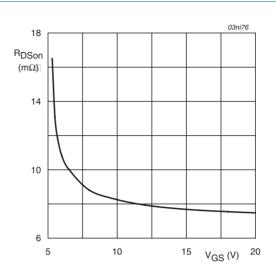


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



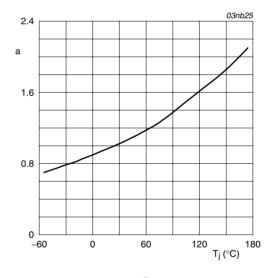
 $T_j = 25^{\circ}C; t_p = 300\mu s$ 

Fig 7. Drain-source on-state resistance as a function of drain current; typical values



$$T_i = 25^{\circ}C; I_D = 50A$$

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values



 $a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$ 

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature

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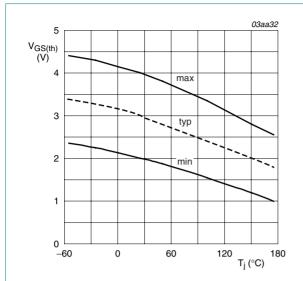
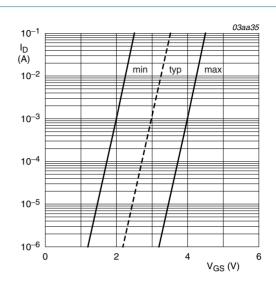


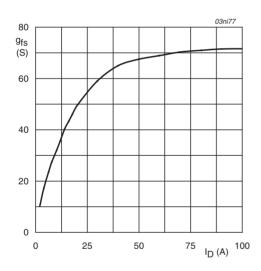
Fig 9. Gate-source threshold voltage as a function of junction temperature

 $I_D = 1 \, mA; V_{DS} = V_{GS}$ 



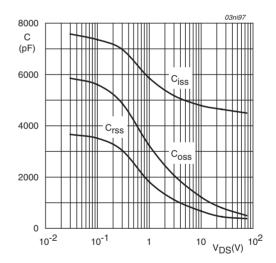
 $T_{j} = 25 \,^{\circ}C; V_{DS} = 5V$ 

Fig 10. Sub-threshold drain current as a function of gate-source voltage



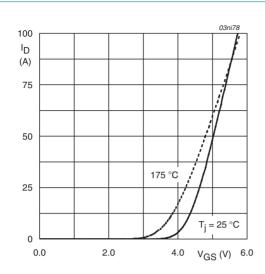
 $T_j = 25^{\circ}C; V_{DS} = 25V$ 

Fig 11. Forward transconductance as a function of drain current; typical values



$$V_{GS} = 0V; f = 1MHz$$

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



 $V_{DS} = 25V$ 

Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values

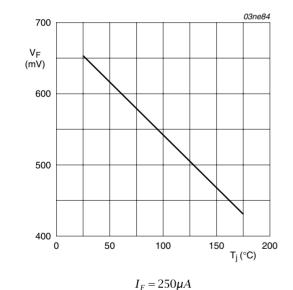
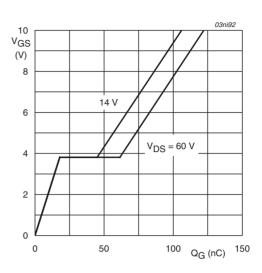
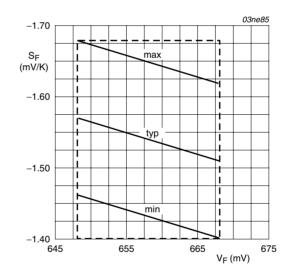


Fig 15. Forward voltage of temperature sense diode as a function of junction temperature; typical values



$$T_i = 25^{\circ}C; I_D = 25A$$

Fig 14. Gate-source voltage as a function of turn-on gate charge; typical values



 $V_F$  at  $T_j = 25^{\circ}C$ ;  $I_F = 250 \mu A$ 

Fig 16. Temperature coefficient of temperature sense diode as a function of forward voltage; typical values

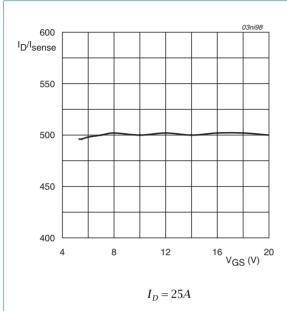


Fig 17. Drain-sense current ratio as a function of gate-source voltage; typical values

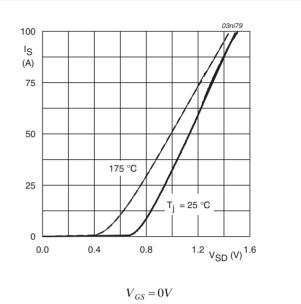


Fig 18. Reverse diode current as a function of reverse diode voltage; typical values

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## Package outline

#### Plastic single-ended surface-mounted package (D2PAK); 7 leads (one lead cropped) **SOT427** $D_1$ mounting base Ď $H_{\mathsf{D}}$ e+e+e+e+e+e **←** 0 **→** 5 mm scale **DIMENSIONS** (mm are the original dimensions) Α Ε Q UNIT A<sub>1</sub> b С $D_1$ $L_{p}$ $H_D$ max. 4.50 1.40 0.85 0.64 2.60 2.90 15.80 1.60 10.30 1.27 4.10 1.27 0.60 0.46 1.20 9.70 2.10 14.80 2.20 REFERENCES **EUROPEAN** OUTLINE **ISSUE DATE PROJECTION VERSION** IEC **JEDEC** JEITA 05-03-09 SOT427

Fig 19. Package outline SOT427 (D2PAK)

06-03-16



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# 8. Revision history

#### Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7C10-75AITE_3	20090217	Product data sheet	-	BUK7C10_75AITE-02
Modifications:	guidelines	of this data sheet has be of NXP Semiconductors. have been adapted to th		•
BUK7C10_75AITE-02 (9397 750 11048)	20030318	Product data sheet	-	BUK7C10_75AITE-01
BUK7C10_75AITE-01 (9397 750 09881)	20020725	Product data sheet	-	-

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### 9. Legal information

#### 9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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#### N-channel TrenchPLUS standard level FET

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